

Search Notes

Application/Control No.

10/574,110

Examiner

Jennifer Y. Cho

Applicant(s)/Patent under
Reexamination

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Art Unit

1621

SEARCHED

Class	Subclass	Date	Examiner
568	438	3/2/2007	JC
560	103	3/5/07	JC
560	210	3/5/07	JC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Search	3/2/2007	JC
Inventor Search	3/2/2007	JC